

# **MOSFET** – N-Channel, Logic Level, POWERTRENCH®

**60 V, 4 A, 60 m**Ω

# FDC5661N-F085

#### **Features**

- $R_{DS(on)} = 47 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 4.3 \text{ A}$
- $R_{DS(on)} = 60 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 4 \text{ A}$
- Typ  $Q_{g(TOT)} = 14.5 \text{ nC at } V_{GS} = 10 \text{ V}$
- Low Miller Charge
- UIS Capability
- AEC-Q101 Qualified and PPAP Capable
- This Device is Pb–Free, Halogen Free/BFR Free and is RoHS Compliant

## **Applications**

- DC-DC Converter
- Motor Drives

### MOSFET MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain to Source Voltage	V <sub>DSS</sub>	60	V
Gate to Source Voltage	V <sub>GS</sub>	±20	V
Drain Current Continuous (V <sub>GS</sub> = 10 V)	I <sub>D</sub>	4.3	Α
Pulsed		20	
Single Pulse Avalanche Energy (Note 1)	E <sub>AS</sub>	81	mJ
Power Dissipation	$P_{D}$	1.6	W
Operating and Storage Temperature	T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Thermal Resistance Junction to Case	$R_{\theta JC}$	30	°C/W
Thermal Resistance Junction to Ambient TO-263, 1in <sup>2</sup> Copper Pad Area	$R_{\theta JA}$	78	°C/W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1.  $E_{AS}$  of 81 mJ is 100% test at L = 14 mH,  $I_{AS}$  = 3.4 A, Starting  $T_{J}$  = 25°C



TSOT23-6 CASE 419BL

#### **MARKING DIAGRAM**



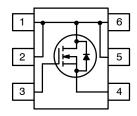
XXX = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

#### **PIN CONNECTIONS**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•	•		
Drain to Source Breakdown Voltage	B <sub>VDSS</sub>	$I_D = 250 \mu A, V_{GS} = 0 V$	60	_	_	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
		T <sub>A</sub> = 150°C	-	-	250	1
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V	-	-	±100	nA
ON CHARACTERISTICS	•		•		-	-
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1	2.0	3	V
Drain to Source On-Resistance	R <sub>DS(on)</sub>			38	47	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 4 A	-	46	60	1
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.3 A T <sub>J</sub> = 150°C	-	69	86	1
DYNAMIC CHARACTERISTICS	•	•	•	•		
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz	_	763	_	pF
Output Capacitance	C <sub>oss</sub>	f = 1 MHz	-	68	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	36	-	pF
Gate Resistance	R <sub>G</sub>	f = 1 MHz	-	2.6	_	Ω
Total Gate Charge at 10 V	Q <sub>g(TOT)</sub>	$V_{GS} = 0$ to 10 V, $V_{DD} = 30$ V, $I_D = 4.3$ A	-	14.5	19	nC
Gate to Source Gate Charge	$Q_{gs}$	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 4.3 A	-	2.4	_	nC
Gate to Drain "Miller" Charge	$Q_{gd}$		-	2.9	_	nC
SWITCHING CHARACTERISTICS	•		•		-	-
Turn-On Time	t <sub>on</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 30 V,	_	-	17.6	ns
Turn-On Delay Time	t <sub>d(on)</sub>	$I_D = 4.3 \text{ A}, R_{GS} = 6 \Omega,$	-	7.2	_	ns
Rise Time	t <sub>r</sub>		-	1.6	_	ns
Turn-Off Delay Time	t <sub>d(off)</sub>		-	19.3	_	ns
Fall Time	t <sub>f</sub>		-	3.1	_	ns
Turn-Off Time	t <sub>off</sub>		-	-	36	ns
DRAIN-SOURCE DIODE CHARACTE	RISTICS			-	-	•
Source to Drain Diode Voltage	V <sub>SD</sub>	I <sub>SD</sub> = 4.3 A	_	0.8	1.25	V
		I <sub>SD</sub> = 2.1 A	-	0.8	1.0	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>SD</sub> = 4.3 A, dI <sub>SD</sub> /dt = 100 A/μs	-	18.4	24	ns
Reverse Recovery Charge	Q <sub>rr</sub>		-	10.0	13	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

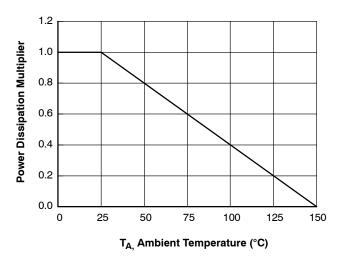


Figure 1. Normalized Power Dissipation vs. Ambient Temperature

Figure 2. Maximum Continuous Drain Current vs. Ambient Temperature

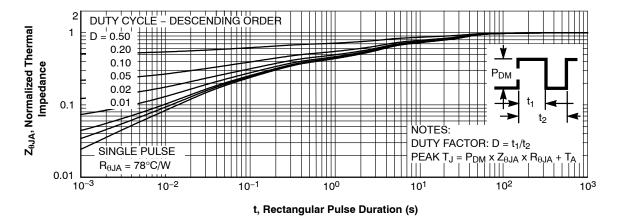


Figure 3. Normalized Maximum Transient Thermal Impedance

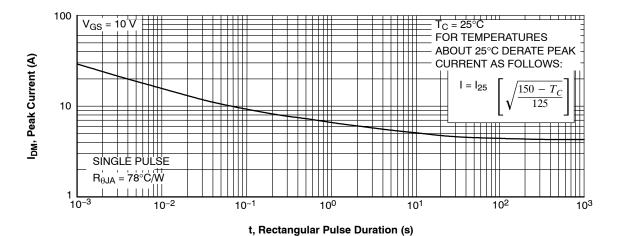


Figure 4. Peak Current Capability

#### TYPICAL CHARACTERISTICS (continued)

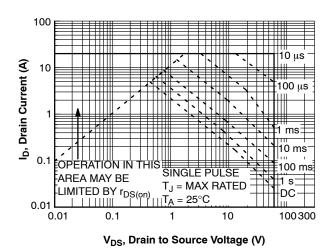


Figure 5. Forward Bias Safe Operating Area

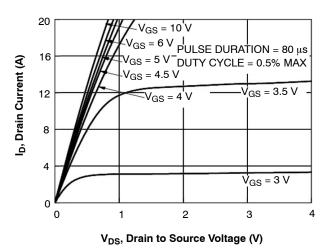


Figure 7. Saturation Characteristics

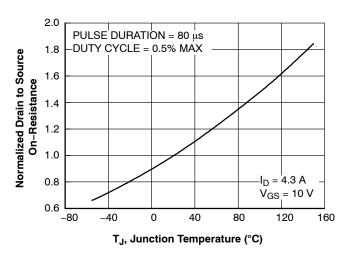


Figure 9. Normalized Drain to Source On Resistance vs. Junction Temperature

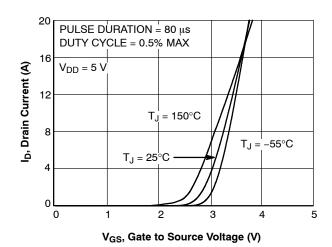


Figure 6. Transfer Characteristics

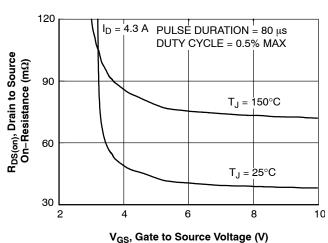


Figure 8. Drain to Source On-Resistance Variation vs. Gate to Source Voltage

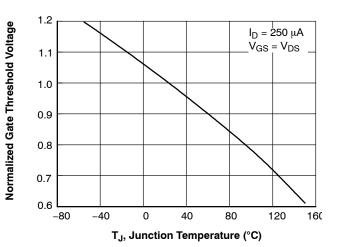
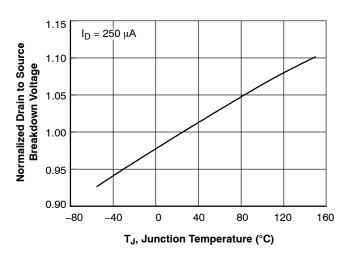


Figure 10. Normalized Gate Threshold Voltage vs. Junction Temperature

#### TYPICAL CHARACTERISTICS (continued)



2000
1000
1000
1000
Ciss
Coss
Coss
100
0.1 1 10 50

V<sub>DS</sub>, Drain To Source Voltage (V)

Figure 11. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

Figure 12. Capacitance vs. Drain to Source Voltage

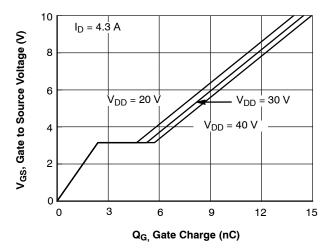


Figure 13. Gate Charge vs. Gate to Source Voltage

#### **ORDERING INFORMATION**

Device Marking	Device	Package	Shipping <sup>†</sup>
.661N	FDC5661N-F085	TSOT23-6 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <a href="https://example.com/BRD8011/D">BRD8011/D</a>.

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0.20 C



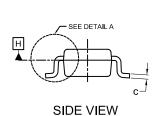
PIN 1 **IDENTIFIER** 

#### TSOT23 6-Lead CASE 419BL **ISSUE A**

**DATE 31 AUG 2020** 

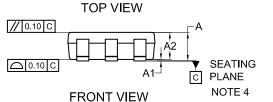
#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
   DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
   PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.25MM PER END. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
- 4. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00	0.05	0.10	
A2	0.70	0.85	1.00	
А3	0.25 BSC			
b	0.25	0.38	0.50	
С	0.10	0.18	0.26	
D	2.80	2.95	3.10	
d	0.30 REF			
Е	2.50	2.75	3.00	
E1	1.30	1.50	1.70	
е	0.95 BSC			
e1	1.90 BSC			
L1	0.60 REF			
L2	0.20	0.40	0.60	
Д	U <sub>o</sub>		10°	

MILLIMETERS



e1

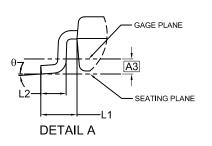
A

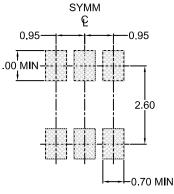
E1

-b

В

0.20 C





## LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.





XXX = Specific Device Code

= Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " • ", may or may not be present. Some products may not follow the Generic Marking.

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